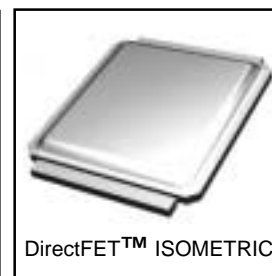
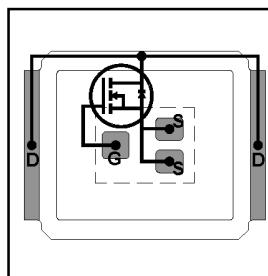


IRF6602

DirectFET™ Power MOSFET

- Application Specific MOSFETs
- Ideal for CPU Core DC-DC Converters
- Low Conduction Losses
- Low Switching Losses
- Low Profile (<0.7 mm)
- Dual Sided Cooling Compatible
- Compatible with existing Surface Mount Techniques

V_{DS}	$R_{DS(on)}$ max	I_D
20V	13mΩ @ $V_{GS} = 10V$	14A
	18.5mΩ @ $V_{GS} = 4.5V$	12A



Description

The IRF6602 combines the latest HEXFET® Power MOSFET Silicon technology with the advanced DirectFET™ packaging to achieve the lowest on-state resistance charge product in a package that has the footprint of an SO-8 and only 0.7 mm profile. The DirectFET package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques. The DirectFET package allows dual sided cooling to maximize thermal transfer in power systems, IMPROVING previous best thermal resistance by 80%.

The IRF6602 balances both low resistance and low charge along with ultra low package inductance to reduce both conduction and switching losses. The reduced total losses make this product ideal for high efficiency DC-DC converters that power the latest generation of processors operating at higher frequencies. The IRF6602 has been optimized for parameters that are critical in synchronous buck converters including $R_{ds(on)}$ and gate charge to minimize losses in the control FET socket.

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain- Source Voltage	20	V
I_D @ $T_C = 25^\circ C$	Continuous Drain Current, V_{GS} @ 10V	46	A
I_D @ $T_A = 25^\circ C$	Continuous Drain Current, V_{GS} @ 10V	14	
I_D @ $T_A = 70^\circ C$	Continuous Drain Current, V_{GS} @ 10V	11.5	
I_{DM}	Pulsed Drain Current ①	120	
P_D @ $T_A = 25^\circ C$	Power Dissipation	5.0	W
P_D @ $T_A = 70^\circ C$	Power Dissipation	3.2	
	Linear Derating Factor	40	mW/°C
V_{GS}	Gate-to-Source Voltage	±20	V
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to + 150	°C

Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient③	—	25	°C/W
$R_{\theta JA}$	Junction-to-Ambient④	—	12.5	
$R_{\theta JA}$	Junction-to-Ambient⑤	—	20	
$R_{\theta JC}$	Junction-to-Case⑥	—	3.0	
$R_{\theta J-PCB}$	Junction-to-PCB mounted	—	1.0	

Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	20	—	—	V	$V_{GS} = 0V, I_D = 100\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.02	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = 1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	10	13	$m\Omega$	$V_{GS} = 10V, I_D = 14A$ ③
		—	14	18.5		$V_{GS} = 4.5V, I_D = 12A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	1.0	—	3.0	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
I_{DSS}	Drain-to-Source Leakage Current	—	—	20	μA	$V_{DS} = 16V, V_{GS} = 0V$
		—	—	125		$V_{DS} = 16V, V_{GS} = 0V, T_J = 70^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{GS} = -20V$

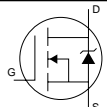
Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
g_{fs}	Forward Transconductance	50	—	—	S	$V_{DS} = 10V, I_D = 12A$
Q_g	Total Gate Charge Cont FET	—	14	21	nC	$V_{GS} = 4.5V, V_{DS} = 16A V, I_D = 12A$
Q_g	Total Gate Charge Sync FET	—	TBA	—		$V_{GS} = 4.5V, V_{DS} < 100mV$
Q_{gs1}	Pre-Vth Gate-Source Charge	—	0.86	—		$V_{DS} = 16V, I_D = 12A$
Q_{gs2}	Post-Vth Gate-Source Charge	—	3.4	—		
Q_{gd}	Gate to Drain Charge	—	4.8	7.5		
Q_{oss}	Output Charge	—	14	—		$V_{DS} = 10V, V_{GS} = 0V$
R_g	Gate Resistance	—	1.8	—	Ω	
$t_{d(on)}$	Turn-On Delay Time	—	TBA	—	ns	$V_{DD} = 15V$
t_r	Rise Time	—	TBA	—		$I_D = 12A$
$t_{d(off)}$	Turn-Off Delay Time	—	TBA	—		$R_G = 5.1\Omega$
t_f	Fall Time	—	TBA	—		$V_{GS} = 4.5V$ ③
C_{iss}	Input Capacitance	—	1350	—	pF	$V_{GS} = 0V$
C_{oss}	Output Capacitance	—	950	—		$V_{DS} = 10V$
C_{rss}	Reverse Transfer Capacitance	—	150	—		$f = 1.0\text{MHz}$

Avalanche Characteristics

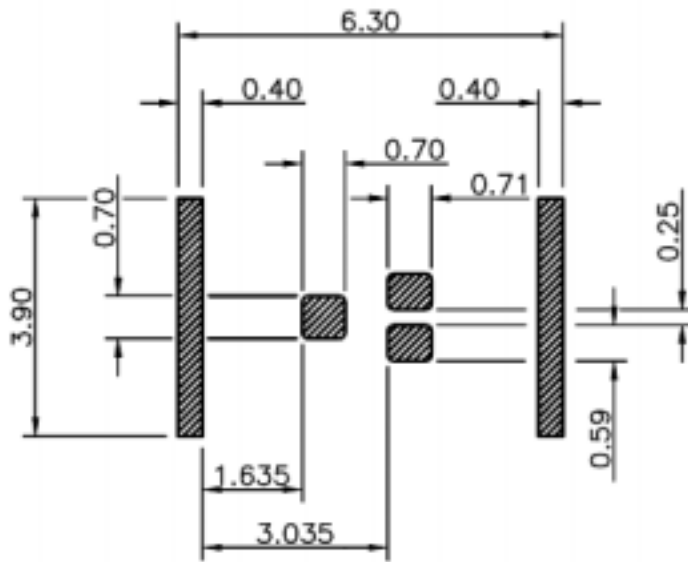
Symbol	Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy②	—	30	mJ
I_{AR}	Avalanche Current①	—	TBA	A

Diode Characteristics

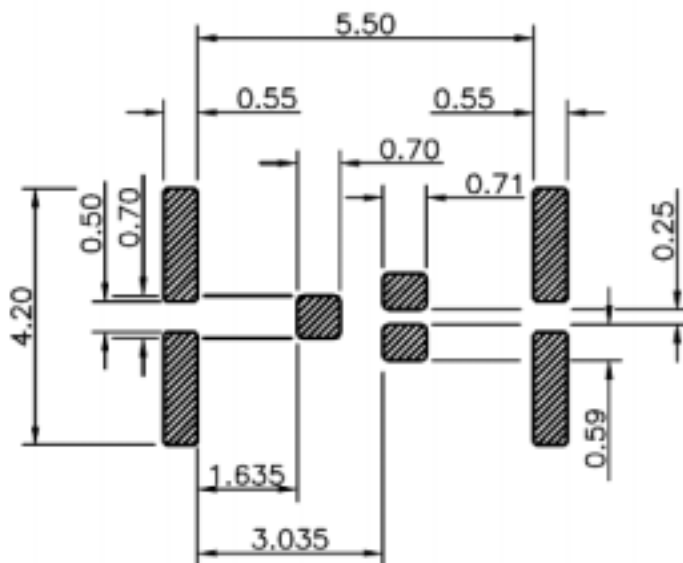
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	14	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	120		
V_{SD}	Diode Forward Voltage	—	—	1.2	V	$T_J = 25^\circ\text{C}, I_S = 12A, V_{GS} = 0V$ ③
		—	0.8	—		$T_J = 125^\circ\text{C}, I_S = 12A, V_{GS} = 0V$ ③
t_{rr}	Reverse Recovery Time	—	TBA	TBA	ns	$T_J = 25^\circ\text{C}, I_F = 12A, V_R = 15V$
Q_{rr}	Reverse Recovery Charge	—	36	54	nC	$di/dt = 100A/\mu s$ ③
$Q_{rr(s)}$	Reverse Recovery Charge (with Parallel Schottky)	—	TBA	TBA	nC	$di/dt = 100A/\mu s$ $V_{DS} = 15V, V_{GS} = 0V, I_S = 12A$

DirectFET™ Pad Layout

Device Pad Layout



PCB Pad Layout

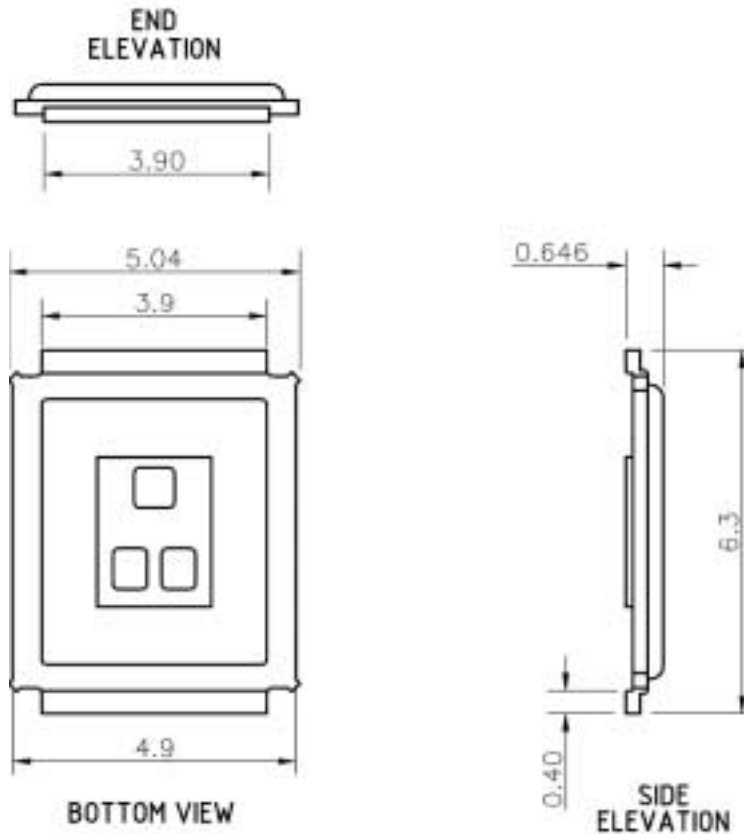


IRF6602

PROVISIONAL

International
IR Rectifier

DirectFET™ Outline Dimension



Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ③ Surface mounted on 1 in square Cu board
- ④ Used double sided cooling, mounting pad
- ⑤ Mounted on minimum footprint full size board with metalized back and with small clip heatsink
- ⑥ T_C measured with thermal couple mounted to top (Drain) of part.

Data and specifications subject to change without notice.
This product has been designed and qualified for the Consumer market.
Qualification Standards can be found on IR's Web site.

International
IR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.01/02

www.irf.com